



AO3407

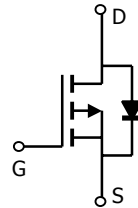
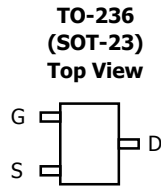
P-Channel Enhancement Mode Field Effect Transistor

General Description

The AO3407 uses advanced trench technology to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use as a load switch or in PWM applications.

Features

- $V_{DS} (V) = -30V$
- $I_D = -4.1 A$
- $R_{DS(ON)} < 52m\Omega (V_{GS} = -10V)$
- $R_{DS(ON)} < 87m\Omega (V_{GS} = -4.5V)$



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|------------------|------------|------------|
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ^A | $T_A=25^\circ C$ | -4.1 | A |
| | $T_A=70^\circ C$ | -3.5 | |
| Pulsed Drain Current ^B | I_{DM} | -20 | |
| Power Dissipation ^A | $T_A=25^\circ C$ | 1.4 | W |
| | $T_A=70^\circ C$ | 1 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | $^\circ C$ |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|--------------|-----|--------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 65 | 90 | $^\circ C/W$ |
| Maximum Junction-to-Ambient ^A | | Steady-State | 85 | |
| Maximum Junction-to-Lead ^C | $R_{\theta JL}$ | 43 | 60 | $^\circ C/W$ |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|------------|-----------|---------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=-250\mu\text{A}, V_{GS}=0\text{V}$ | -30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=-24\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | -1 -5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=-250\mu\text{A}$ | -1 | -1.8 | -3 | V |
| $I_{D(ON)}$ | On state drain current | $V_{GS}=-4.5\text{V}, V_{DS}=-5\text{V}$ | -10 | | | A |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}=-10\text{V}, I_D=-4.1\text{A}$ $T_J=125^\circ\text{C}$ | | 40.5 57 | 52 73 | m Ω |
| | | $V_{GS}=-4.5\text{V}, I_D=-3\text{A}$ | | 64 | 87 | |
| g_{FS} | Forward Transconductance | $V_{DS}=-5\text{V}, I_D=-4\text{A}$ | 5.5 | 8.2 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=-1\text{A}, V_{GS}=0\text{V}$ | | -0.77 | -1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | -2.2 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=-15\text{V}, f=1\text{MHz}$ | | 700 | | pF |
| C_{oss} | Output Capacitance | | | 120 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 75 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | | 10 | | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q_g | Total Gate Charge (10V) | $V_{GS}=-4.5\text{V}, V_{DS}=-15\text{V}, I_D=-4\text{A}$ | | 14.3 | | nC |
| Q_g | Total Gate Charge (4.5V) | | | 7 | | nC |
| Q_{gs} | Gate Source Charge | | | 3.1 | | nC |
| Q_{gd} | Gate Drain Charge | | | 3 | | nC |
| $t_{D(on)}$ | Turn-On Delay Time | $V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, R_L=3.6\Omega,$ $R_{GEN}=3\Omega$ | | 8.6 | | ns |
| t_r | Turn-On Rise Time | | | 5 | | ns |
| $t_{D(off)}$ | Turn-Off Delay Time | | | 28.2 | | ns |
| t_f | Turn-Off Fall Time | | | 13.5 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=-4\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 27 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=-4\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 15 | | nC |

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any a given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

D: The static characteristics in Figures 1 to 6, 12, 14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.